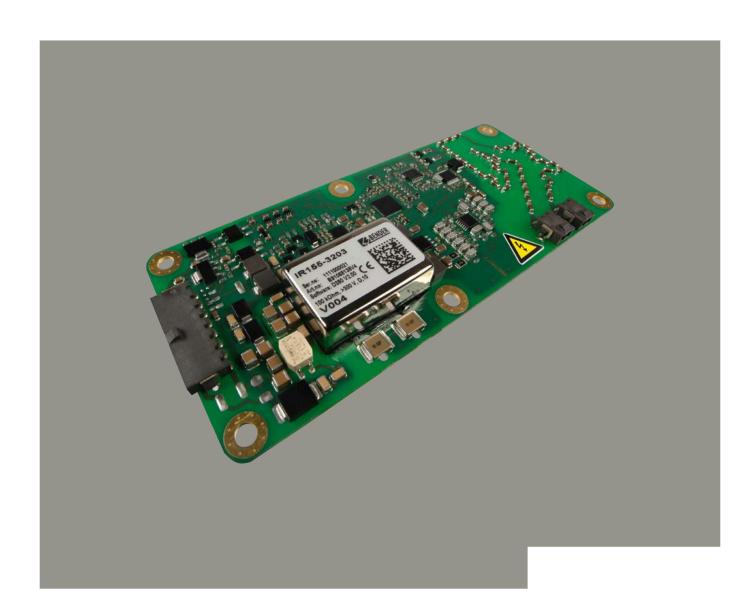
# ISOMETER® IR155-3203/IR155-3204

Insulation monitoring device (IMD) for unearthed DC drive systems (IT systems) in electric vehicles

### **Version V004**





## Insulation monitoring device (IMD) for unearthed DC drive systems (IT systems) in electric vehicles



#### **Device features**

- Suitable for 12 V and 24 V systems
- · Automatic device self test
- Continuous measurement of the insulation resistance 0...10  $M\Omega$ 
  - Response time for the first measurement of the system state (SST) is < 2 s after switching the supply voltage on
  - Response time < 20 s for insulation resistance measurement (DCP)
- Automatic adaptation to the existing system leakage capacitance (≤ 1 µF)
- Detection of earth faults and interruption of the earth connection
- Insulation monitoring of AC and DC insulation faults for unearthed systems (IT systems) 0...1000 V
- Undervoltage detection for voltages below 500 V (adjustable at factory by Bender)
- Short-circuit proof outputs for:
  - Fault detection (high-side output)
  - Measured value (PWM 5...95 %) and status (f = 10...50 Hz) at high or inverted low-side driver (M<sub>HS</sub>/M<sub>LS</sub> output)
- Protective coating (SL 1307 FLZ)

#### **Approvals**



#### **ATTENTION**



Observe precautions for handling electrostatic sensitive devices.

Handle only at safe work stations.

#### **ATTENTION**



The device is monitoring HIGH VOLTAGE.

Be aware of HIGH VOLTAGE near to the device.

#### **Product description**

The ISOMETER® IR155-3203/-3204 monitors the insulation resistance between the insulated and active HV-conductors of an electrical drive system ( $U_n = DC\ 0\ V...1000\ V$ ) and the reference earth (chassis ground  $\blacktriangleright$  Kl.31). The patented measurement technology is used to monitor the condition of the insulation on the DC side as well as on the AC motor side of the electrical drive system. Existing insulation faults will be signalled reliably, even under high system interferences, which can be caused by motor control processes, accelerating, energy recovering etc.

Due to its space-saving design and optimised measurement technology, the device is optimised for use in hybrid or fully electric vehicles. The device meets the increased automotive requirements with regard to the environmental conditions (e.g. temperatures and vibration, EMC...).

The fault messages (insulation fault at the HV-system, connection or device error of the IMD) will be provided at the integrated and galvanic isolated interface (high- or low-side driver). The interface consists of a status output ( $OK_{HS}$  output) and a measurement output ( $M_{HS}/M_{LS}$  output). The status output signalises errors or that the system is error free, i.e the "good" condition as shown by the "Operating principle PWM driver" diagram on page 5. The measurement output signalises the actual insulation resistance. Furthermore, it is possible to distinguish between different fault messages and device conditions, which are base frequency encoded.

#### **Function**

The ISOMETER® IR155-3203/-3204 generates a pulsed measuring voltage, which is superimposed on the IT system via terminals L+/L- and E/KE. The latest measured insulation condition is available as a pulse-width-modulated (PWM) signal at terminals  $M_{\rm HS}$  (for IR155-3204) or  $M_{\rm LS}$  (for IR155-3203). The connection between the terminals E/KE and the chassis ground (  $\blacktriangleright$  KI.31) is continuously monitored. Therefore it is necessary to install two separated conductors from the terminals E or KE to chassis ground.



Connection monitoring of the earth terminals E/KE is specified for  $R_F \le 4 M\Omega$  if the ISOMETER® is connected as shown in the application diagram on page 3.

Once power is switched on, the device performs an initialisation and starts the system state (SST) measurement. The ISOMETER® provides the first estimated insulation resistance during a maximum time of 2 seconds. The DCP measurement ( > continuous measurement method) starts subsequently. Faults in the connecting wires or functional faults will be automatically recognised and signalled.

During operation, a self test is carried out automatically every five minutes. The interfaces will not be influenced by these self tests.



Connection monitoring of the earth terminals E/KE may not work as intended when  $R_F > 4 M\Omega$  if the supply terminals (Kl.15/Kl.31) are not galvanically isolated from the chassis earth (Kl.31).

#### Standards

| Corresponding standard   | ds and regulations |
|--------------------------|--------------------|
| IEC 61557-8              | 2014-12            |
| IEC 61010-1              | 2010-06            |
| IEC 60664-1              | 2004-04            |
| ISO 6469-3               | 2011-12            |
| ISO 23273-3              | 2006-11            |
| ISO 16750-1              | 2006-08            |
| ISO 16750-2              | 2010-03            |
| ISO 16750-4              | 2010-04            |
| E1 (ECE regulation No. 1 | 0 revision 5)      |
| acc. 72/245/EWG/EEC      | 2009/19/EG/EG      |
| DIN EN 60068-2-38        | Z/AD:2010          |
| DIN EN 60068-2-30        | Db:2006            |
| DIN EN 60068-2-14        | Nb:2010            |
| DIN EN 60068-2-64        | Fh:2009            |
| DIN EN 60068-2-27        | Ea:2010            |

#### \* \* Normative exclusion

The device went through an automotive test procedure in combination with multi customer requirements reg. ISO16750-x.

The standard IEC61557-8 will be fulfilled by creating the function for LED warning and test button at the customer site if necessary.

The device includes no surge and load dump protection above 50 V. An additional central protection is necessary.

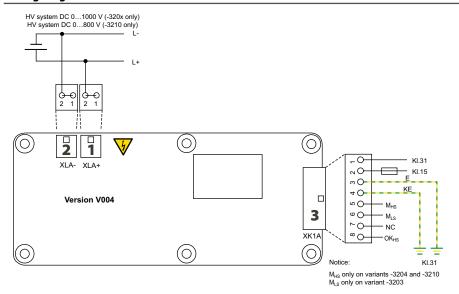
#### **Abbreviations**

DCP Direct Current Pulse SST Speed Start Measuring



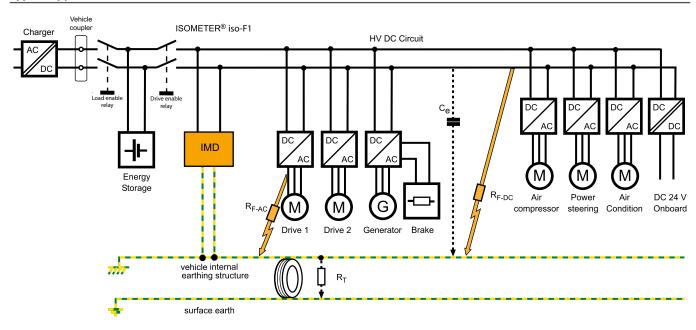
AC/DC

#### Wiring diagrams



| 1 | Connector XLA+ |                         |                                  |
|---|----------------|-------------------------|----------------------------------|
|   | Pin 1+2        | L+                      | Line Voltage                     |
| 2 | Connector XLA- |                         |                                  |
|   | Pin 1+2        | L-                      | Line Voltage                     |
| 3 | Connector XK1A |                         |                                  |
|   | Pin 1          | Kl. 31                  | Chassis ground/electronic ground |
|   | Pin 2          | Kl. 15                  | Supply voltage                   |
|   | Pin 3          | Kl. 31                  | Chassis ground                   |
|   | Pin 4          | Kl. 31                  | Chassis ground (separate line)   |
|   | Pin 5          | M <sub>HS</sub>         | Data Out, PWM (high side)        |
|   | Pin 6          | M <sub>LS</sub>         | Data Out, PWM (low side)         |
|   | Pin 7          | n.c.                    |                                  |
|   | Pin 8          | <i>OK</i> <sub>HS</sub> | Status Output (high side)        |
|   |                |                         |                                  |

#### **Typical application**





#### **Technical data**

| Insulation coordination acc. to         | o IEC 60664-1   |
|---|---|
| Protective separation (reinforced       | insulation)   |
|   | between (L+/L-) – (Kl. 31, Kl. 15, E, KE, M <sub>HS</sub> , M <sub>LS</sub> , OK <sub>HS</sub> )                        |
| Voltage test                            | AC 3500 V/1 min   |
| Supply/IT system being monitore         | d   |
| Supply voltage $U_S$                    | DC 1036 V   |
| Max. operating current I <sub>S</sub>   | 150 mA  |
| Max. current I <sub>k</sub>             | 2 A   |
|   | 6 A/2 ms inrush current   |
| HV voltage range (L+/L-) U <sub>n</sub> | AC 01000 V (peak value)   |
|   | 0660 V RMS (10 Hz1 kHz)   |
|   | DC 01000 V  |
| Power consumption                       | < 2 W   |
| · · · · · · · · · · · · · · · · · · ·   |   |
| Response values                         |   |
| Response value hysteresis (DCP)         | 25 %  |
| Response value Ran                      | 100 kΩ1 ΜΩ  |
| Undervoltage detection                  | 0500 V  |
| Moscuring range                         |   |
| Measuring range                         |   |
| Measuring range                         | 010 ΜΩ  |
| Undervoltage detection                  | 0500 V default setting: 0 V (inactive)  |
| Relative uncertainty                    |   |
| SST (≤ 2 s)                             | $good > 2* R_{an}; bad < 0.5* R_{an}$   |
| Relative uncertainty DCP                | 085 kΩ ▶ ±20 kΩ   |
| (default setting 100 kΩ)                | 100 kΩ10 MΩ ▶ ±15%  |
| Relative uncertainty output M (fu       | indamental frequency) $\pm 5\%$ at each frequency   |
|   | (10 Hz; 20 Hz; 30 Hz; 40 Hz; 50 Hz)   |
| Relative uncertainty                    |   |
| undervoltage detection                  | $U_{\rm n} \ge 100 \rm V  \blacktriangleright  \pm 10 \%$ ; at $U_{\rm n} \ge 300 \rm V  \blacktriangleright  \pm 5 \%$ |
| Relative uncertainty (SST)              | "Good condition" $\geq 2^* R_{an}$  |
| • • •                                   | "Bad condition" $\leq 0.5$ * $R_{an}$   |
|   | <del>-</del>  |
| No Insulation fault                     | <u> </u>  |
| (high)                                  | V   V ))   *  |
|   | / / / / / / / / / / / / / / / / / / /   |
| Insulation fault _                      |   |
| (low)                                   | Bossons value =   |
|   | $_{50kΩ}$ Response value = $_{100kΩ}$ $_{200kΩ}$ $_{10MΩ}$  |
| Relative uncertainty DCP                | 100 kΩ10 MΩ ±15 %   |
| •                                       | 100 kΩ1.2 MΩ $\triangleright$ ±15 % to ±7 %   |
|   | 1.2 MΩ ▶ ±7 %   |
|   | 1.210 MΩ ▶ ±7 % to ±15 %  |
|   | 10 MΩ ► ±15 %   |
|   | <b>↑</b>  |
|   | +15%  |
|   | +7%   |
|   | 0   |
|   | -7%   |
|   | -15%  |
|   | ψ                     100kΩ         1.2MΩ         10MΩ  |
| Abcolute uncortainte                    |   |
| Absolute uncertainty                    | 085 kΩ ► ±20 kΩ   |
| +                                       | 1.5ΜΩ   |
|   | <u></u>   |
|   | ],  |
|   | +84κΩ   |
|   | +20kΩ   |
|   | +15kΩ   |
|   | 0   |
|   | -15k0   |

```
Time response
Response time t_{an} (OK<sub>HS</sub>; SST)
                                                                                     t_{an} \le 2 \text{ s (typ.} < 1 \text{ s at } U_n > 100 \text{ V})
Response time t_{an} (OK_{HS}; DCP)
(when changing over from R_F = 10 \text{ M}\Omega to R_{an}/2; at C_e = 1 \mu\text{F}; U_n = DC 1000 \text{ V})
                                                                                                   t_{\rm an} \leq 20 \, {\rm s} \, ({\rm at} \, F_{\rm ave} = 10^*)
                                                                                                    t_{an} \le 17.5 \text{ s (at } F_{ave} = 9)
                                                                                                    t_{an} \le 17.5 \text{ s (at } F_{ave} = 8)
                                                                                                       t_{\rm an} \le 15 \, \mathrm{s} \, (\mathrm{at} \, F_{\rm ave} = 7)
                                                                                                    t_{an} \le 12.5 \text{ s (at } F_{ave} = 6)
                                                                                                    t_{\rm an} \le 12.5 \, {\rm s} \, ({\rm at} \, F_{\rm ave} = 5)
                                                                                                       t_{\rm an} \le 10 \, \mathrm{s} \, (\mathrm{at} \, F_{\rm ave} = 4)
                                                                                                      t_{an} \le 7.5 \text{ s (at } F_{ave} = 3)
                                                                                                      t_{an} \le 7.5 \text{ s (at } F_{ave} = 2)
                                                                                                         t_{\rm an} \le 5 \, \mathrm{s} \, (\mathrm{at} \, F_{\rm ave} = 1)
                                                                                             during the self test t_{an} + 10 s
Switch-off time t_{ab} (OK_{HS}; DCP)
(when changing over from R_{an}/2 to R_F=10 M\Omega; at C_e=1 \mu F; U_n=DC 1000 V
                                                                                                     t_{ab} \le 40 \text{ s (at } F_{ave} = 10)
                                                                                                       t_{ab} \le 40 \text{ s (at } F_{ave} = 9)
                                                                                                       t_{ab} \le 33 \text{ s (at } F_{ave} = 8)
                                                                                                       t_{ab} \le 33 \text{ s (at } F_{ave} = 7)
                                                                                                       t_{ab} \le 33 \text{ s (at } F_{ave} = 6)
                                                                                                       t_{ab} \le 26 \text{ s (at } F_{ave} = 5)
                                                                                                       t_{ab} \le 26 \text{ s (at } F_{ave} = 4)
                                                                                                       t_{ab} \le 26 \text{ s (at } F_{ave} = 3)
                                                                                                       t_{ab} \le 20 \text{ s (at } F_{ave} = 2)
                                                                                                       t_{ab} \le 20 \text{ s (at } F_{ave} = 1)
                                                                                                during a self test t_{ab} + 10 s
Duration of the self test
                                                                  (every five minutes; should be added to t_{an}/t_{ab})
Measuring circuit
System leakage capacitance Ce
                                                                                                                                ≤ 1 µF
Smaller measurement range and increased measuring time at Ce
                                                                                                                                > 1 µF
                                                                                            (e.g. max. range 1 M\Omega @ 3 \muF,
```

 $t_{\rm an} = 68$  s when changing over from  $R_{\rm F}$  1 M $\Omega$  to  $R_{\rm an}/2$ )

±40 V

±33 μA

 $\geq 1.2~\text{M}\Omega$ 

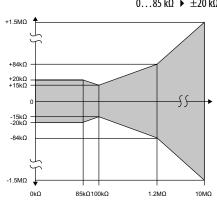
 $\geq 1.2 \text{ M}\Omega$ 

#### Impedance Z<sub>i</sub> at 50 Hz Internal DC resistance Ri

\*  $F_{ave} = 10$  is recommended for electric and hybrid vehicles

Measuring voltage U<sub>M</sub>

Measuring current  $I_{\rm M}$  at  $R_{\rm F}=0$ 





#### Output

#### Measurement output (M)

 $M_{\rm HS}$  switches to  $U_{\rm S}-2$  V (3204)

(external pull-down resistor to KI. 31 necessary 2.2 kΩ)

 $M_{LS}$  switches to KI. 31 + 2 V (3203)

(external pull-up resistor to KI. 15 regired 2.2  $k\Omega$ 

**0 Hz**  $\blacktriangleright$  Hi > short-circuit to  $U_{\rm b}$  + (Kl. 15); Low > IMD off or short-circuit to Kl. 31

10 Hz ➤ Normal condition
Insulation measurement DCP;
starts two seconds after power on;
First successful insulation measurement at ≤ 17.5 s
PWM active 5...95 %

20 Hz ➤ undervoltage condition
Insulation measurement DCP (continuous measurement);
starts two seconds after power on;
PWM active 5...95 %
First successful insulation measurement at ≤ 17.5 s

Undervoltage detection 0...500 V (Bender configurable)

**30 Hz** ➤ Speed start measurement Insulation measurement (only good/bad evaluation) starts directly after power on ≤ 2 s; PWM 5...10 % (good) and 90...95 % (bad)

**40 Hz** ► Device error Device error detected; PWM 47.5...52.5 %

**50 Hz** ► Connection fault earth Fault detected on the earth connection (Kl. 31)

PWM 47.5...52.5 %

#### Status output (OK<sub>HS</sub>)

 $OK_{HS}$  switches to  $U_S - 2$  V (external pull-down resistor to Kl. 31 required 2.2 k $\Omega$ )

High ► No fault; R<sub>F</sub> > response value

Low ► Insulation resistance ≤ response value detected;

Device error; Fault in the earth connection

Undervoltage detected or device switched off

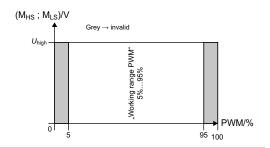
#### Operating principle PWM driver

• Condition "Normal" and "Undervoltage detected" (10 Hz; 20 Hz)

Duty cycle  $5 \% = > 50 \text{ M}\Omega \ (\infty)$ Duty cycle  $50 \% = 1200 \text{ k}\Omega$ Duty cycle  $95 \% = 0 \text{ k}\Omega$ 

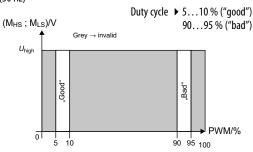
$$R_{\rm F} = \frac{90 \% \text{ x } 1200 \text{ k}\Omega}{dc_{\rm meas} - 5\%} - 1200 \text{ k}\Omega$$

 $dc_{\text{meas}} = \text{measured duty cycle } (5 \%...95 \%)$ 



#### Operating principle PWM driver

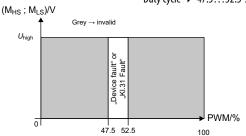
Condition "SST" (30 Hz)



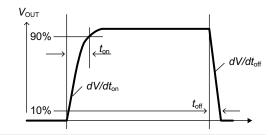
#### Operating principle PWM driver

• Condition "Device error" and "Kl.31 fault" (40 Hz; 50 Hz;)

Duty cycle ▶ 47.5...52.5 %



| Load current I <sub>L</sub>              | 80 mA       |
|--|-------------|
| Turn-on time ▶ to 90 % V <sub>out</sub>  | max. 125 μs |
| Turn-off time ▶ to 10 % V <sub>out</sub> | max. 175 µs |
| Slew rate on ▶ 1030 % V <sub>out</sub>   | max. 6 V/µs |
| Slew rate off ▶ 7040 % V <sub>out</sub>  | max. 8 V/µs |
| Timing 3204 (inverse to 3203)            | ·           |



#### **EMC**

| Load dump protection        | < 50 V                |
|-----------------------------|-----------------------|
| Measurement method          | Bender-DCP technology |
| Factor averaging            |                       |
| F <sub>ave</sub> (output M) | 110 (factory set: 10) |

#### **ESD** protection

| Contact discharge – directly to terminals     | ≤ 10 kV |
|---|---------|
| Contact discharge – indirectly to environment | ≤ 25 kV |
| Air discharge — handling of the PCB           | ≤ 6 kV  |

#### Connection

On-board connectors

TYCO-MICRO MATE-N-LOK

1 x 2-1445088-8

(KI. 31, KI.15, E, KE, M<sub>HS</sub>, M<sub>LS</sub>, OK<sub>HS</sub>

2 x 2-1445088-2 (L+, L-); The connection between the respective connecting pins at L+ or L- may only be used as redundancy. Cannot be used for looping through!

Crimp contacts

TYCO-MICRO MATE-N-LOK Gold 14 x 1-794606-1

Conductor cross section: AWG 20...24

Enclosure for crimp contacts TYCO-MICRO MATE-N-LOK receptor HSG single R -1445022-8 TYCO-MICRO MATE-N-LOK receptor HSG single R -1445022-2

#### **General data**

| Necessary crimp tongs (TYCO) | 91501-1                           |
|------------------------------|-----------------------------------|
| Operating mode/mounting      | continuous operation/any position |
| Temperature range            | -40+105 ℃                         |
| Voltage failure              | ≤ 2 ms                            |
| Flammability class acc. to   | UL 94 V-0                         |

#### Mounting

M4 metal screws with locking washers between screw head and PCB. Torx, T20 with a maximum tightening torque of 4 Nm for the screws. Furthermore, a maximum of 10 Nm tightening torque to the PCB at the mounting points.

Mounting and connector kits are not included in delivery, but are available as accessories. The maximum diameter of the mounting points is 10 mm.

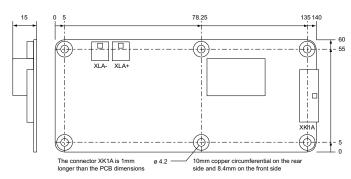
Before mounting the device, ensure sufficient insulation between the device and the vehicle or the mounting points (min. 11.4 mm to other parts). If the device is mounted on a metal or conductive subsurface, this subsurface has to be at earth potential (Kl.31; vehicle mass).

| conductive subsurface, this subsurface has to be at earth potential (KL31; vehicle mass). |  |  |
|---|--|--|
| Deflection  | max. 1 % of the length or width of the PCB |  |
| Coating   | thick-film lacquer                         |  |
| Weight  | 52 g ±2 g                                  |  |

#### **Dimension diagram**

Dimensions in mm

PCB dimensions (L x W x H) 140 mm x 60 mm x 15 mm



#### **Ordering information**

| Parameters                | Response value R <sub>an</sub> | <b>F</b> ave | Undervoltage detection | Measured value output | Туре       | Art. No.       |           |            |
|---------------------------|--------------------------------|--------------|------------------------|-----------------------|------------|----------------|-----------|------------|
| Continuously set value    | 100 kO                         | 10           | 300 V                  | Low side              | IR155-3203 | B91068138V4    |           |            |
| Continuously set value    | 100 kΩ                         |              | 10                     | 10                    | 10         | 0 V (inactive) | High side | IR155-3204 |
| Customer-specific setting | 100 kΩ1 MΩ                     | 110          | 0 5007                 | Low side              | IR155-3203 | B91068138CV4   |           |            |
|                           |                                |              | 0500 V                 | High side             | IR155-3204 | B91068139CV4   |           |            |

#### Accessories

| Type designation         | Art. No.  |  |
|--------------------------|-----------|--|
| Fastening set            | B91068500 |  |
| Connector set IR155-32xx | B91068501 |  |

#### **Example for ordering**

IR155-3204-100k $\Omega$ -0V + B 9106 8139V4 IR155-3204-200k $\Omega$ -100V + B 9106 8139CV4

The parameters, i.e. the response value and undervoltage protection value must be included in the order.



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